

Search Notes

Application/Control No.

10/088,868

Examiner

Christopher L. Chin

Applicant(s)/Patent under
Reexamination

LENZ ET AL.

Art Unit

1641

SEARCHED

Class	Subclass	Date	Examiner
Updated	Search	5/31/2005	CC
436	536		
436	538		
436	539		
436	540		
436	541	5/31/2005	CC

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR